

**Search Notes**

Application No.

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Examiner

Paul Dinh

Applicant(s)

TEIG ET AL.

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	10-15	10/2/2003	PD
above	update	7/6/2004	PD

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, IEEE	10/2/2003	PD